# Product Preview 75 A, 950 V Field Stop Trench IGBT

Trench Field Stop  $4^{\text{th}}$  generation High Speed IGBT co–packaged with full current rated diode

#### Features

- Maximum Junction Temperature :  $T_J = 175^{\circ}C$
- Positive Temperature Co-efficient for Easy Parallel Operating
- High Current Capability
- Low Saturation Voltage:  $V_{CE(Sat)} = 1.69 \text{ V} (Typ.) @ I_C = 75 \text{ A}$
- Fast Switching
- Tighten Parameter Distribution
- These Devices are Pb-Free and are RoHS Compliant

#### Applications

- Solar Inverter
- PFC
- DC/DC Converter

#### MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector to Emitter Voltage	V <sub>CES</sub>	950	V
Gate to Emitter Voltage Transient Gate to Emitter Voltage	V <sub>GES</sub>	±20 ±30	V
	IC	150 75	A
Pulsed Collector Current (Note 1)	I <sub>LM</sub>	300	А
Pulsed Collector Current (Note 2)	I <sub>CM</sub>	300	А
Diode Forward Current $@T_C = 25^{\circ}C$ $@T_C = 100^{\circ}C$	lF	150 75	A
Pulsed Diode Forward Current (Note 2)	I <sub>FM</sub>	300	А
Maximum Power Dissipation $@T_C = 25^{\circ}C$ $@T_C = 100^{\circ}C$	PD	434 217	W
Operating Junction / Storage Temperature Range	TJ, TSTG	-55 to +175	°C
Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5 seconds	ΤL	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

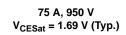
1. VCC = 700 V, VGE = 15 V, IC = 300 A, RG = 26 Ω, Inductive Load, 100% Tested

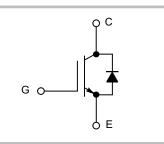
2. Pulse width limited by max Junction temperature. Defined by design. Not subject to production test



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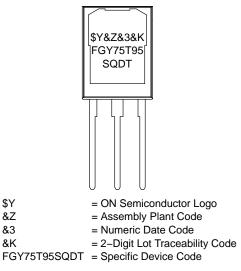
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#### MARKING DIAGRAM



#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 2 of this data sheet.

This document contains information on a product under development. ON Semiconductor reserves the right to change or discontinue this product without notice.

#### **ORDERING INFORMATION**

Part Number	Top Marking	Package	Shipping
FGY75T95SQDT	FGY75T95SQDT	TO-247-3LD (Pb-Free)	30 Units / Rail

#### THERMAL CHARACTERISTICS

Rating	Symbol	Value	Unit
Thermal resistance junction-to-case, for IGBT	$R_{ extsf{ heta}JC}$	0.35	°C/W
Thermal resistance junction-to-case, for Diode	$R_{ extsf{ heta}JC}$	0.23	°C/W
Thermal resistance junction-to-ambient	$R_{ hetaJA}$	40	°C/W

### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Parameter	Test Conditions	Symbol	Min	Тур	Мах	Unit
OFF CHARACTERISTICS						•
Collector–emitter breakdown voltage, gate–emitter short–circuited	V <sub>GE</sub> = 0 V, I <sub>C</sub> = 1 mA	BVCES	950			V
Temperature Coefficient of Breakdown Voltage	V <sub>GE</sub> = 0 V, I <sub>C</sub> = 1 mA	Δ <u>BVCES</u> ΔTJ		0.96		V/°C
Collector–emitter cut–off current, gate– emitter short–circuited	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 950 V	ICES			250	μΑ
Gate leakage current, collector⊠emitter short–circuited	$V_{GE} = 20 \text{ V}$ , $V_{CE} = 0 \text{ V}$	IGES			±400	nA
ON CHARACTERISTICS		•		•		•
Gate-emitter threshold voltage	$V_{GE} = V_{CE}$ , $I_C = 75$ mA	VGE(th)	3.4	4.84	6.4	V
Collector-emitter saturation voltage	$V_{GE}$ = 15 V, I <sub>C</sub> = 75 A $V_{GE}$ = 15 V, I <sub>C</sub> = 75 A, T <sub>J</sub> = 175°C	VCE(sat)		1.69 2.25	2.11	V
DYNAMIC CHARACTERISTICS		·				
Input capacitance	$V_{CE} = 30 \text{ V}, \text{ V}_{GE} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$	Cies		4770		pF
Output capacitance		Coes		241		
Reverse transfer capacitance		Cres		19.7		
Gate charge total	$V_{CE} = 600 \text{ V}, I_C = 75 \text{ V}, V_{GE} = 15 \text{ V}$	Qg		137		nC
Gate to emitter charge		Qge		33.2		
Gate to collector charge		Qgc		38.6		
SWITCHING CHARACTERISTICS, INDU	CTIVE LOAD					
Turn–on delay time	$T_J = 25^{\circ}C$	td(on)		28.8		ns
Rise time	$V_{CC} = 600 \text{ V}, I_C = 37.5 \text{ A}$ Rg = 4.7 Ω	t <sub>r</sub>		16.0		
Turn–off delay time	V <sub>GE</sub> = 15 V Inductive Load	td(off)		104.0		
Fall time		t <sub>f</sub>		30.4		
Turn-on switching loss	]	Eon		2.1		mJ
Turn–off switching loss		Eoff		1.0		
Total switching loss	1	Ets		3.2		

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
Turn-on delay time	T <sub>J</sub> = 25°C	td(on)		31.2		ns
Rise time	$V_{CC} = 600 \text{ V}, \text{ I}_{C} = 75 \text{ A}$ Rg = 4.7 $\Omega$	t <sub>r</sub>		58.4		
Turn-off delay time	V <sub>GE</sub> = 15 V Inductive Load	td(off)		96.0		
Fall time		t <sub>f</sub>		65.6		
Turn-on switching loss		Eon		5.4		mJ
Turn-off switching loss		Eoff		2.1		
Total switching loss		Ets		7.6		
Turn-on delay time	T <sub>J</sub> = 175°C	td(on)		28.8		ns
Rise time	$V_{CC}$ = 600 V, I <sub>C</sub> = 37.5 A Rg = 4.7 Ω	t <sub>r</sub>		17.6		
Turn-off delay time	V <sub>GE</sub> = 15 V Inductive Load	td(off)		117.0		
Fall time		t <sub>f</sub>		60.8		
Turn-on switching loss		Eon		4.1		mJ
Turn-off switching loss		Eoff		1.7		
Total switching loss		Ets		5.8		
Turn-on delay time	T <sub>J</sub> = 175°C	td(on)		28.8		ns
Rise time	$V_{CC} = 600 \text{ V}, \text{ I}_{C} = 75 \text{ A}$ Rg = 4.7 $\Omega$	t <sub>r</sub>		60.8		
Turn-off delay time	V <sub>GE</sub> = 15 V Inductive Load	td(off)		106.0		
Fall time		t <sub>f</sub>		92.8		
Turn-on switching loss		Eon		8.8		mJ
Turn-off switching loss		Eoff		3.2		
Total switching loss		Ets		12.0		
DIODE CHARACTERISTICS				1		
Forward voltage	I <sub>F</sub> = 75 A I <sub>F</sub> = 75 A, T <sub>J</sub> = 175°C	V <sub>F</sub>		2.03 1.76	2.51	V
Reverse Recovery Energy	T <sub>J</sub> = 25°C	E <sub>rec</sub>		314		uJ
Reverse Recovery Time	$V_R = 600 \text{ V}, I_F = 37.5 \text{ A}$ $dI_F/dt = 1000 \text{ A}/\mu\text{s}$	t <sub>rr</sub>		105		ns
Reverse Recovery Charge		Q <sub>rr</sub>		1635		nC
Reverse Recovery Energy	T <sub>J</sub> = 25°C	E <sub>rec</sub>		2390		uJ
Reverse Recovery Time	V <sub>R</sub> = 600 V, I <sub>F</sub> = 75 A dI <sub>F</sub> /dt = 1000 A/μs	t <sub>rr</sub>		259		ns
Reverse Recovery Charge		Q <sub>rr</sub>		7515		nC
Reverse Recovery Energy	T <sub>J</sub> = 175°C	E <sub>rec</sub>		454		uJ
Reverse Recovery Time	$V_{R} = 600 \text{ V}, I_{F} = 37.5 \text{ A}$ $dI_{F}/dt = 1000 \text{ A}/\mu\text{s}$	t <sub>rr</sub>		148		ns
Reverse Recovery Charge	αι <sub>F</sub> /αι = 1000 Α/μs	Q <sub>rr</sub>		2436		nC

#### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
Reverse Recovery Energy	T <sub>J</sub> = 175°C	E <sub>rec</sub>		2790		uJ
Reverse Recovery Time	V <sub>R</sub> = 600 V, I <sub>F</sub> = 75 A dI <sub>F</sub> /dt = 1000 A/μs	t <sub>rr</sub>		294		ns
Reverse Recovery Charge		Q <sub>rr</sub>		9175		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **TYPICAL CHARACTERISTICS**

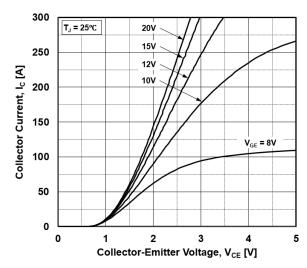
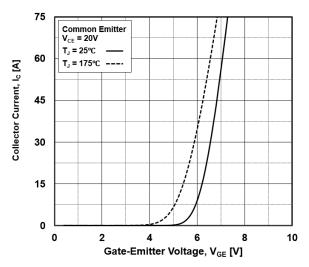
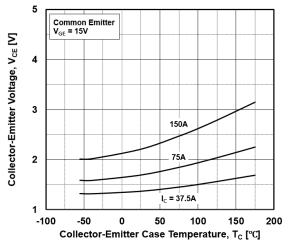
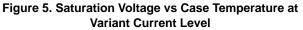


Figure 1. Typical Output Characteristics ( $T_J = 25^{\circ}C$ )



**Figure 3. Transfer Characteristics** 





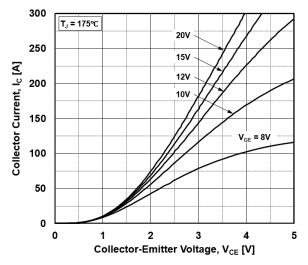


Figure 2. Typical Output Characteristics (T<sub>J</sub> = 175°C)

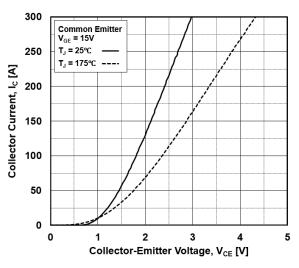
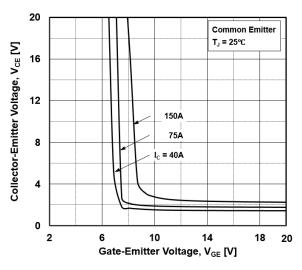


Figure 4. Typical Saturation Voltage Characteristics





#### **TYPICAL CHARACTERISTICS**

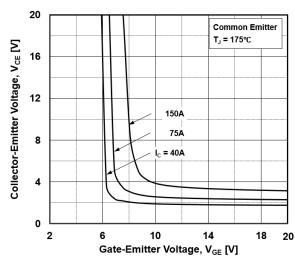


Figure 7. Saturation Voltage vs.  $V_{GE}$  (T<sub>J</sub> = 175°C)

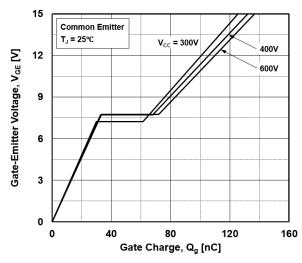
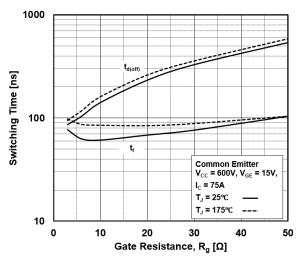
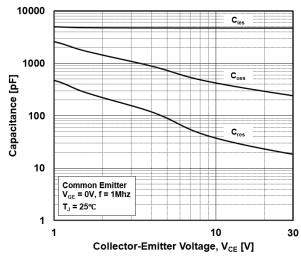


Figure 9. Gate Charge Characteristics ( $T_J = 25^{\circ}C$ )







**Figure 8. Capacitance Characteristics** 

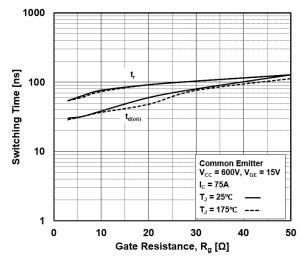
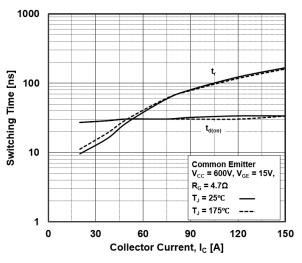
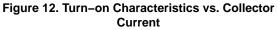


Figure 10. Turn-on Characteristics vs. Gate Resistance





#### **TYPICAL CHARACTERISTICS**

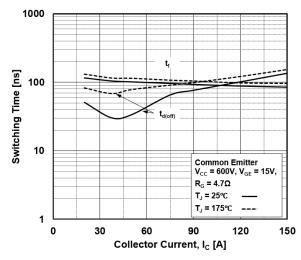


Figure 13. Turn-off Characteristics vs. Collector Current

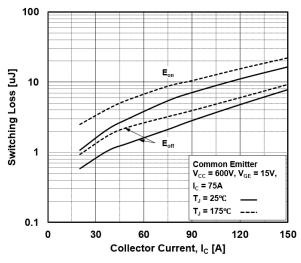


Figure 15. Switching Loss vs. Collector Current

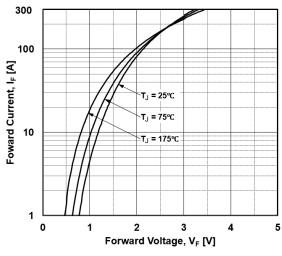


Figure 17. (Diode) Forward Characteristics vs (Normal I–V)

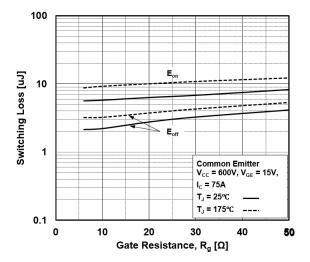


Figure 14. Switching Loss vs. Gate Resistance

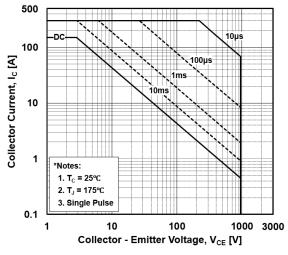


Figure 16. SOA Characteristics (FBSOA)

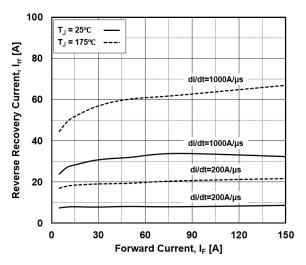


Figure 18. (Diode) Reverse Recovery Current



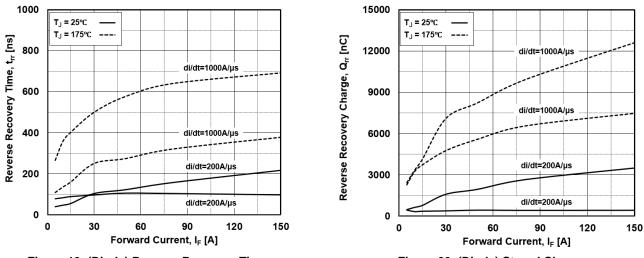
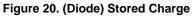


Figure 19. (Diode) Reverse Recovery Time



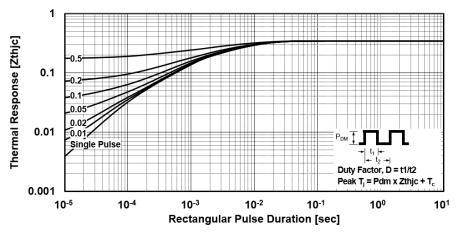


Figure 21. Transient Thermal Impedance of IGBT

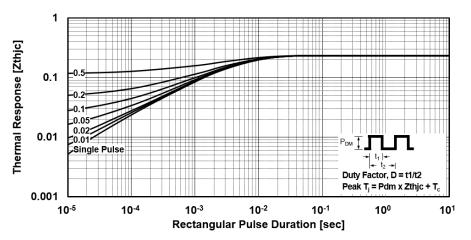
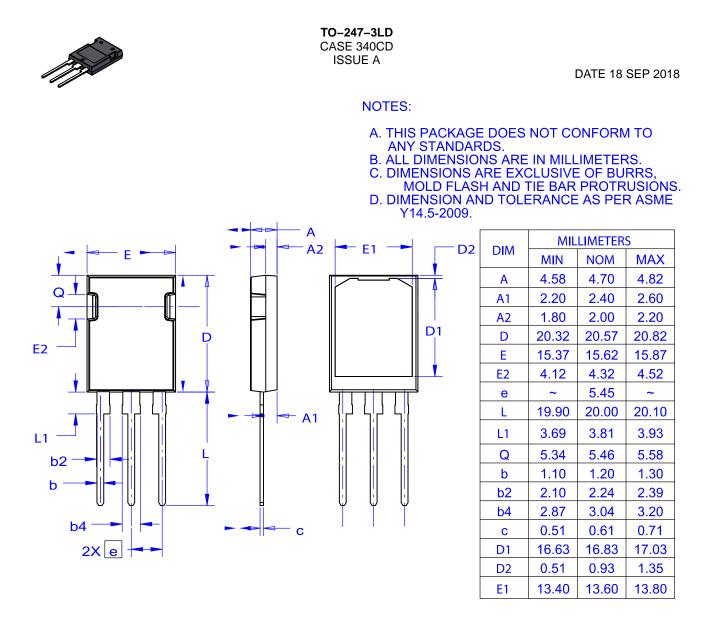


Figure 22. Transient Thermal Impedance of Diode

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